	Application/Control No.	Applicant(s)/Patent under Reexamination	
•	10/529,669	HEKSTRA ET AL.	
	Examiner	Art Unit	
	Jean W. Désir	2622	

SEARCHED					
Class	Subclass	Date	Examiner		
348	742 743 760	9/26/2007	JWD		
	744				
	758				
	759				
353	84				
	85				
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
EAST	9/26/2007	JWD			